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Renesas Technology Corp. Customer Support Dept. April 1, 2003



Cautions

Keep safety first in your circuit designs!

(iii) prevention against any malfunction or mishap.

1. Renesas Technology Corporation puts the maximum effort into making semiconductor products better and more reliable, but there is always the possibility that trouble may occur with them. Trouble with semiconductors may lead to personal injury, fire or property damage.

Remember to give due consideration to safety when making your circuit designs, with appropriate measures such as (i) placement of substitutive, auxiliary circuits, (ii) use of nonflammable material or

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Silicon N-Channel/P-Channel Power MOS FET Array



ADE-208-1215 (Z) 1st. Edition Mar. 2001

Application

High speed power switching

Features

• Low on-resistance

N-channel: $R_{DS(on)} \le 0.17$, $V_{GS}=10$ V, $I_D=2.5$ A P-channel: $R_{DS(on)} \le 0.2$, $V_{GS}=-10$ V, $I_D=-2.5$ A

• Capable of 4 V gate drive

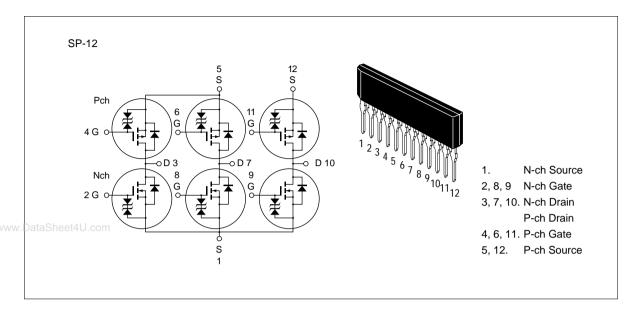
• Low drive current

• High speed switching

• High density mounting

• Suitable for H-bridged motor driver

Outline



Absolute Maximum Ratings (Ta = 25°C) (1 Unit)

		Ratings		
Item	Symbol	Nch	Pch	Unit
Drain to source voltage	$V_{\scriptscriptstyle DSS}$	60	-60	V
Gate to source voltage	$V_{\rm GSS}$	±20	±20	V
Drain current	I _D	5	– 5	Α
Drain peak current	I _{D(pulse)} *1	20	-20	Α
Body to drain diode reverse drain current	I _{DR}	5	- 5	Α
Channel dissipation	Pch (Tc = 25°C)*2	36		W
	Pch*2	4.8		W
Channel temperature	Tch	150		°C
Storage temperature	Tstg	-55 to	+150	°C

Notes: 1. PW \leq 10 μ s, duty cycle \leq 1%

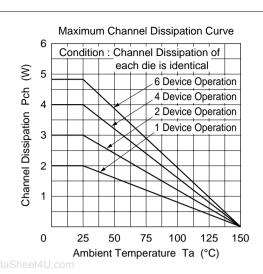
2. 6 Device Operation

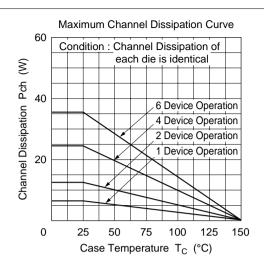
Electrical Characteristics (Ta = 25°C) (1 Unit)

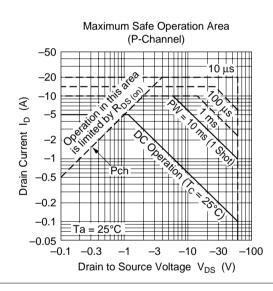
		N cha	annel		P channel				
Item	Symbol	Min	Тур	Max	Min	Тур	Max	Unit	Test conditions
Drain to source breakdown voltage	$V_{(BR)DSS}$	60	_	_	-60	_	_	V	$I_{D} = 10 \text{ mA}, V_{GS} = 0$
Gate to source breakdown voltage	$V_{(BR)GSS}$	±20	_	_	±20	_	_	V	$I_{G} = \pm 100 \ \mu A, \ V_{DS} = 0$
Gate to source leak current	I _{GSS}	_	_	±10	_	_	±10	μΑ	$V_{GS} = \pm 16 \text{ V}, V_{DS} = 0$
Zero gate voltage drain current	I _{DSS}	_	_	250	_	_	-250	μΑ	$V_{DS} = 50 \text{ V}, V_{GS} = 0$
Gate to source cutoff voltage	$V_{GS(off)}$	1.0	_	2.0	-1.0	_	-2.0	V	$I_{D} = 1 \text{ mA}, V_{DS} = 10 \text{ V}$
Static drain to source on state resistance	R _{DS(on)}	_	0.13	0.17	_	0.15	0.2	Ω	$I_D = 2.5 \text{ A},$ $V_{GS} = 10 \text{ V}^{*1}$
		_	0.18	0.24	_	0.20	0.27	Ω	$I_D = 2.5 \text{ A}, V_{GS} = 4 \text{ V}^{*1}$
Forward transfer admittance	y _{fs}	2.7	4.5	_	2.7	5.0	_	S	$I_D = 2.5 \text{ A},$ $V_{DS} = 10 \text{ V}^{*1}$
Input capacitance	Ciss	_	400	_	_	900	_	pF	$V_{DS} = 10 \text{ V}, V_{GS} = 0,$
Output capacitance	Coss	_	220	_	_	460	_	pF	f = 1 MHz
Reverse transfer capacitance	Crss	_	60	_	_	130	_	pF	_
Turn-on delay time	t _{d(on)}	_	5	_	_	8	_	ns	$I_D = 2.5 \text{ A}, V_{GS} = 10 \text{ V},$
Rise time	t _r	_	30	_	_	35	_	ns	$R_L = 12 \Omega$
Turn-off delay time	t _{d(off)}	_	170	_	_	180	_	ns	_
Fall time	t _f	_	75	_	_	85	_	ns	_
Body to drain diode forward voltage	V_{DF}	_	1.0			-1.0	_	V	I _F = 5 A, V _{GS} = 0
Body to drain diode reverse recovery time	t _{rr}	_	100	_	_	170	_	ns	$I_F = 5 \text{ A}, V_{GS} = 0,$ diF/dt = 50 A/ μ s

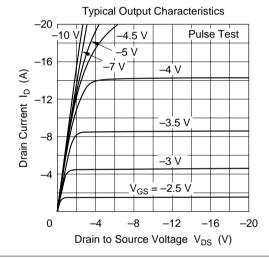
Note: 1. Pulse Test

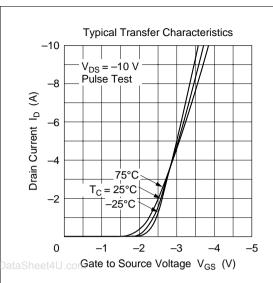
Polarity of test conditions for P channel device is reversed.

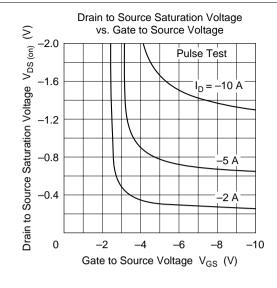


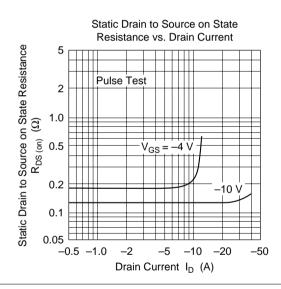


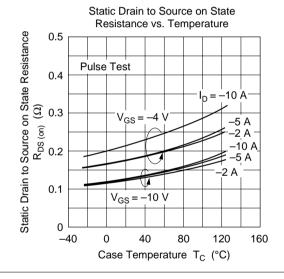


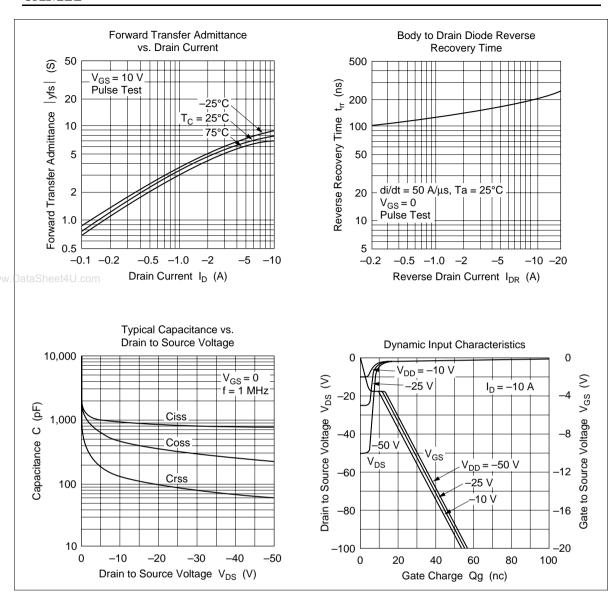


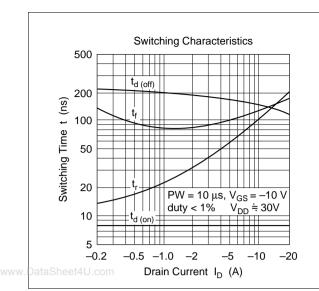


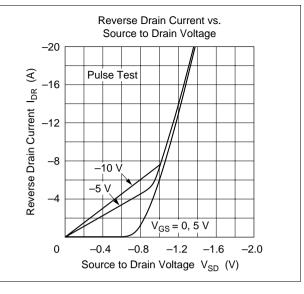


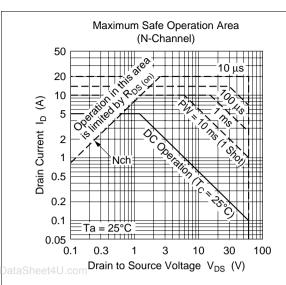


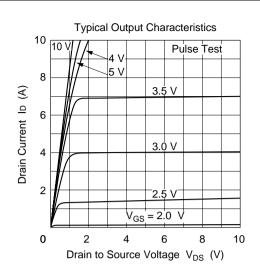


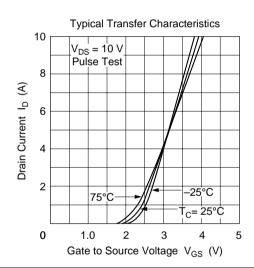


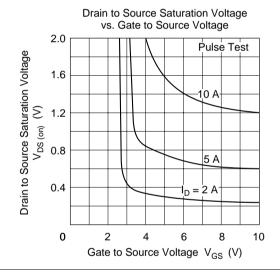


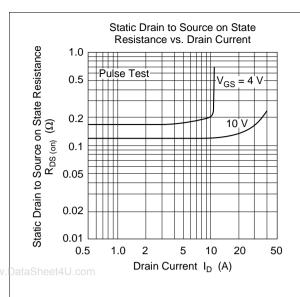


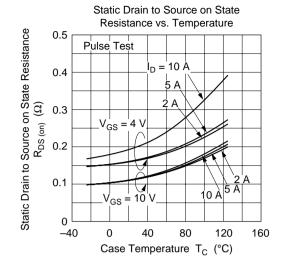


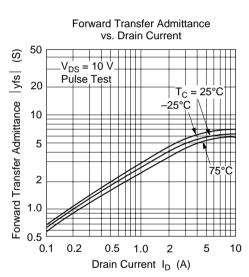


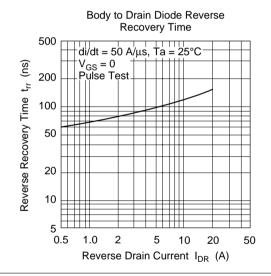


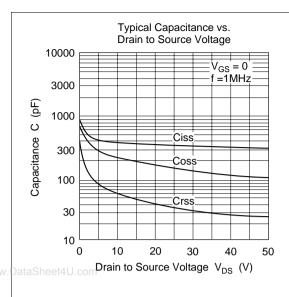


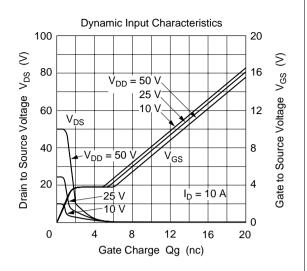


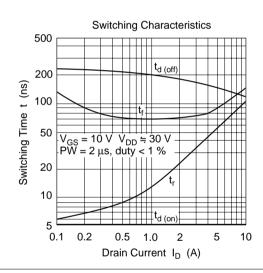


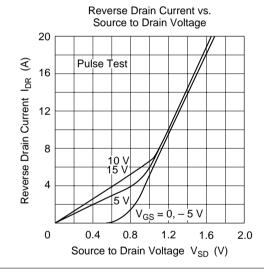




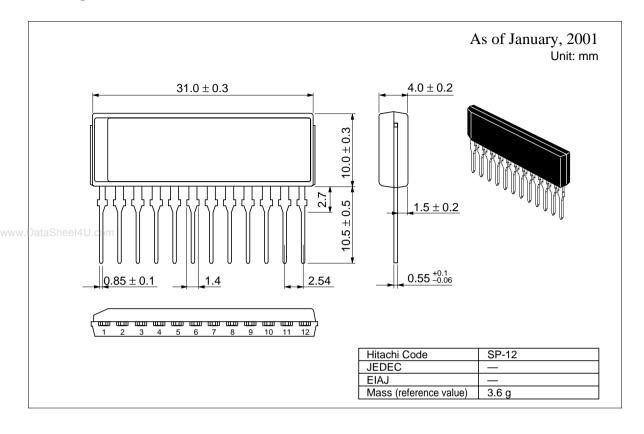








Package Dimensions



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